Search Notes

Application/Control No	App	lication	/Cont	rol	No.
------------------------	-----	----------	-------	-----	-----

601

Applicant(s)/Patent under Reexamination

10/722,691

INDECK ET AL.
Art Unit

Examiner

JEAN B. FLEURANTIN

2162

SEARCHED						
Class	Subclass	Date	Examiner			
707	1-10	4/29/2006	JBF			
707	100-104.1	4/29/2006	JBF			
707	200-206	4/29/2006	JBF			
709	214	4/29/2006	JBF			
711	1, 103	4/29/2006	JBF			
711	111-112	4/29/2006	JBF			
711	145	4/29/2006	JBF			
711	172	4/29/2006	JBF			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
707	1	4/29/2006	JBF		
707	3, 6 200	4/29/2006	JBF		
711	1 112	4/29/2006	JBF		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST (US PG PUB, US PT, EPO, JPO, DERWENT AND IBM TDB)	4/29/2006	JBF		
707/CCLS AND 711/CCLS AND 709/CCLSAND ALL RELATED APPLICATIONS FOR POSSIBLE DOUBLE PATENTING	4/29/2006	JBF		
NPL - ACM	4/29/2006	JBF		
NPL - IEEE	4/29/2006	JBF		
CONSULTED 101 HELP PANEL M. BOOKBINDER	1/5/2006	JBF		